



Good Morning!

Good Afternoon!

Good Evening!

1st ODSA Chiplet Business Workshop

Ravi Agarwal

Open Domain-Specific Architecture, Chiplet
Business Workstream lead

Technical Sourcing, Facebook



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THANK YOU

Workshop Sponsors:

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ASE GROUP



Start Time	End Time	Topic
07:30	08:00	Opening Coffee Sponsorship #1
08:00	08:04	Welcome
08:04	08:08	ODSA how/what/where/why
08:08	08:32	State of the art of Chiplets
08:08	08:16	Need for Establishing a Chiplet Ecosystem
08:16	08:24	Chiplet business challenges for AI accelerator
08:24	08:32	HIR status update (Chiplet Business Challenges)
08:32	08:40	Business Challenges and Opportunities of Chiplets in Heterogeneous Acceleration
Chiplet Value Chain Discussion Design-->Build-->Deliver		
08:40	09:23	Design
08:40	08:48	Chiplets in Space
08:48	09:23	Moderator: Allan Synopsys: Manuel Cadence: Rishi Alphawave: Tony
09:23	09:38	Coffee Break Sponsorship #2
09:38	10:40	Build
09:38	09:45	Chiplet Economic constraints
09:45	10:40	Moderator: Andreas Samsung: Max ASE: Eelco JCET: Swami Teradyne: Regan
10:40	10:55	Coffee you Break Sponsorship #3
10:55	11:58	Deliver
10:55	11:03	Business consideration for Chiplet based compute products
11:03	11:58	Moderator: David Microchip: Anu Marvell: Ramin Google: Ben Alibaba: Weifeng FB: Nicolaas Microsoft: Ishwar



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ODSA Business Workshop.

Bapi Vinnakota

Open Domain-Specific Architecture,
Sub-project lead

System Architect, Broadcom

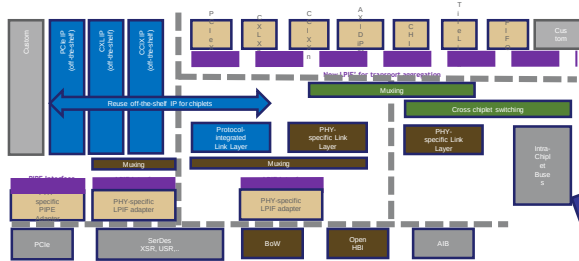


Welcome!

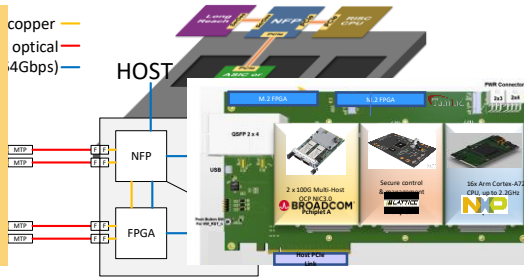
- Our biggest workshop ever!
 - HUUUUGE effort from DJ, Ravi, Rishi, many others
- After the workshop
 - Participate actively, join a work stream!
- ODSA meets Fridays at 8 AM Pacific, work streams meet weekly
 - <https://www.opencompute.org/wiki/Server/ODSA>
- Next few Fridays
 - BoW Test Chip Proposals
 - Chiplet Market Survey
 - Chiplets from LETI
 - SW PoC workshop
 - Memory

ODSA Charter

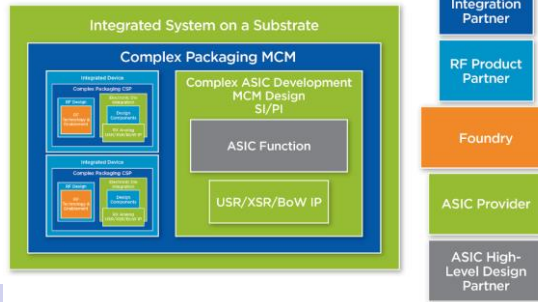
Open D2D
Interface
Reduce barrier to
interoperation



Reference
Designs
Starting point for
new designs



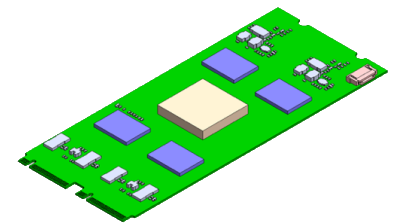
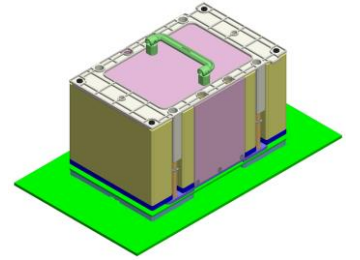
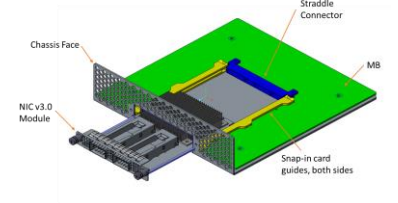
Reference
Workflows
Reusable, open
practices



ODSA Activities

Chiplet Marketplace

Integrate best-in-class
chiplets from multiple
vendors through open
interfaces



OCP modular
form factors

ODSA Workstreams

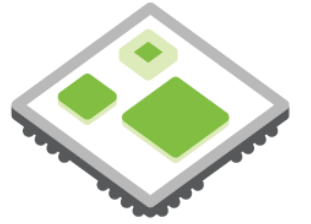
Attendance and/or participation do not imply corporate endorsement

Each group meets weekly, details at <https://www.opencompute.org/wiki/Server/ODSA>

Workstream	Leader	Participants	Objective
PHY Layer	Robert Wang 	    	PCIe PIPE adapter
Bunch of Wires	Mark Kuemerle 	     	Low cost D2D PHY
CDX	Jawad Nasrullah 	    	Chiplet design exchange
Biz 9 AM Fridays	Ravi Agarwal 	    	Chiplet workflowP
PoC hardware	JP Balachandran 	   	PoC board design
PoC software	Kevin Drucker 	    	Application/Infra software
Link layer	Open 	    	ODSA Stack
OpenHBI	Kenneth Ma 	    	High perf D2D PHY
End user	Dharmesh Jani	   	
BoW Test Chip		Sub-project lead: Bapi Vinnakota 	

Please Help, Join Us!

- Join a work stream, each meets weekly
- Help with the PoC, software, use case dev,
- Review, help complete documents in flight
- Need packaging and test definition and work streams
- Make chiplets with, IP for, the open ODSA stack
- <https://www.opencompute.org/wiki/Server/ODSA>



OPEN DOMAIN
SPECIFIC
ARCHITECTURE



SERVER



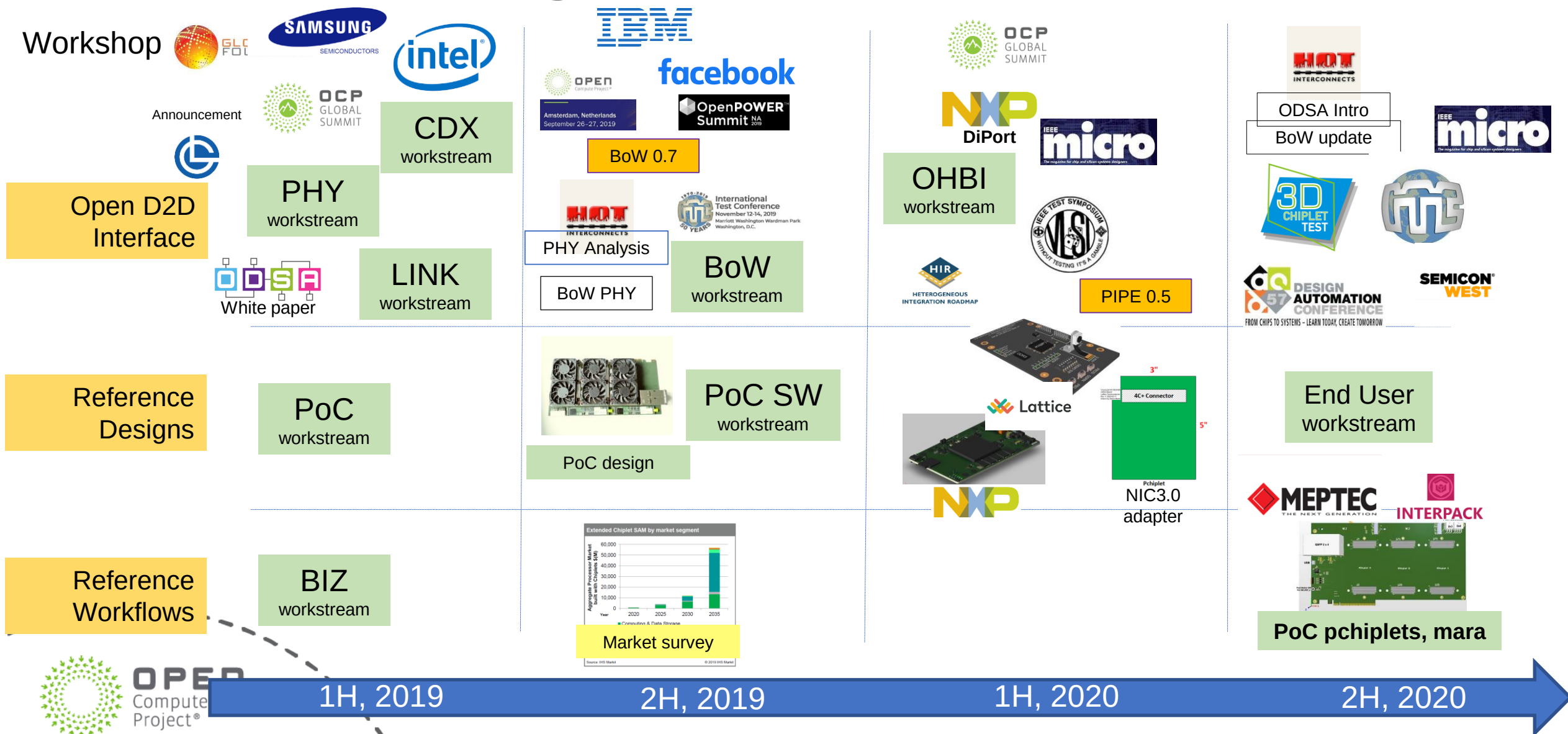
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Reference

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ODSA Progress

details at <https://www.opencompute.org/wiki/Server/ODSA>



For More Information

[ODSA Wiki](#): All workshops, minutes of weekly calls, workstreams (open access)

Specification proposals:

Bunch of Wires [GitHub repo](#) (open access)

[PIPE adapter](#) (PCIe over D2D), [DiPort](#) (AXI over D2D) (open, but need to request access)

[ODSA PoC Demo](#) (open access), [ODSA PoC Implementation Specification](#) (open, but need to request access)

In-flight

LPIF, LPIF' proposal

ODSA PoC SW

Open HBI specification (needs CLA)

Technical Papers/Talks

[ODSA white paper](#), ODSA Wiki

R. Farjadrad, M. Kuemerle, B. Vinnakota, “A Bunch-of-Wires (BoW) Interface for Interchiplet Communication”, IEEE Micro, Jan. 2020

G. Taylor, R. Farjadrad, B. Vinnakota, “High Capacity On-Package Physical Link Considerations”, Hot Interconnects, Aug. 2019

D. Jani, “Musings on Domain Specific Accelerators, Open Compute Project and Cambrian Explosion”, LinkedIn

M. Hutner, et al “Test Challenges in a Chiplet Marketplace”, VLSI Test Symposium, Apr. 2020

B. Vinnakota, “The Open Domain-Specific Architecture: An Introduction”, Design Automation Conference, July. 2020

D. Ratchkov, J. Nasarullah, “Power Modeling in Chiplets”, Design Automation Conference, July. 2020

S.Ardalan et al, “Bunch of Wires PHY: An Open D2D Interface”, Hot Interconnect 2020

K. Drucker et al, “The Open Domain-Specific Architecture”, Hot Interconnect 2020

S. Ardalan et al, “Bunch of Wires Interface: Interchiplet Link Testing and Loopback”, 7th Int. Workshop on 3D and Chiplet Test, Nov 2020

S.Ardalan et al, “Bunch of Wires PHY: An Open D2D Interface”, IEEE Micro 2021

B. Vinnakota et al, “The Open Domain-Specific Architecture”, IEEE Micro 2021

ODSA track at the OCP Global Tech Summit.

Need for Establishing a Chiplet Ecosystem

Javier DeLaCruz, ARM

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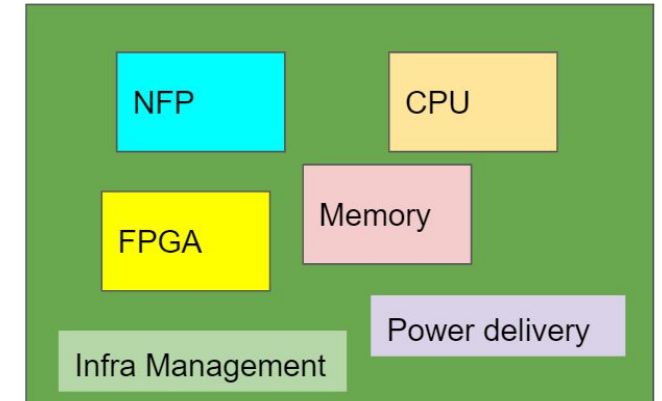
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What is a Chiplet?

A Chiplet is defined by having an **interface** optimized for die-to-die connectivity within a package

A Chiplet lacks the drive strength to be packaged independently

Ideally this creates a system that is more efficient than using conventional die or packaged parts

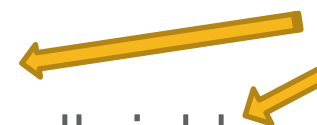


Mara, ODSA idealized chiplet concept

Drivers and Barriers of Chiplets

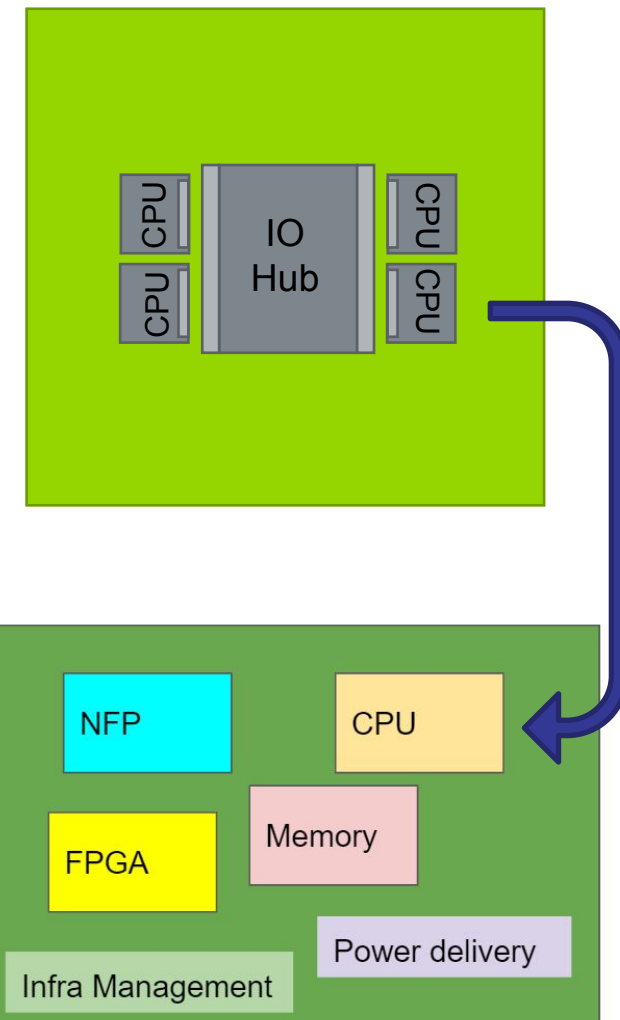
- Three main drivers exist for chiplets
 - Reticle Limits, needing more silicon area
 - Cost Savings, partition die to improve overall yield
 - **Heterogeneity**
- Barriers for Heterogeneity
 - Tapeout costs for each chiplet
 - Starting from scratch may not be practical
 - Common interface standards (phy, control, etc.)
 - Worst case interconnect pitch may drive package technology
 - Lack of chiplet marketplace and data (testability, thermal, pitch, interfaces, software, yield coverage, etc.)
 - Who owns chiplet inventory, yield, etc? (not an issue for vertical integration)

Vertically
Integrated



It Takes a Village

- Create elements with community reusability in mind
- Not all elements need advanced nodes
- It is likely that at least one device is custom (or an FPGA) and that will tie elements together
- IP vendors likely need to work with partners to market chiplets
- Many chiplet needs in voltage regulation, CPU, memory, etc.
- Opportunity for marketplace development in the industry



Mara, ODSA idealized chiplet concept

Thank You

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Chiplet business challenges for AI accelerators

Arvind Kumar
IBM Research
ODSA March 2021 Business Workshop

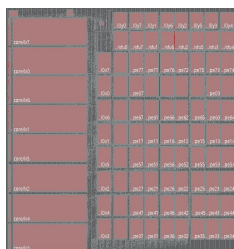
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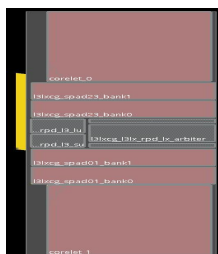
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IBM Research PoV on Chiplet Value Proposition

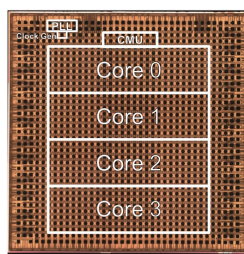
- IBM Research has developed an AI core optimized for DNN processing



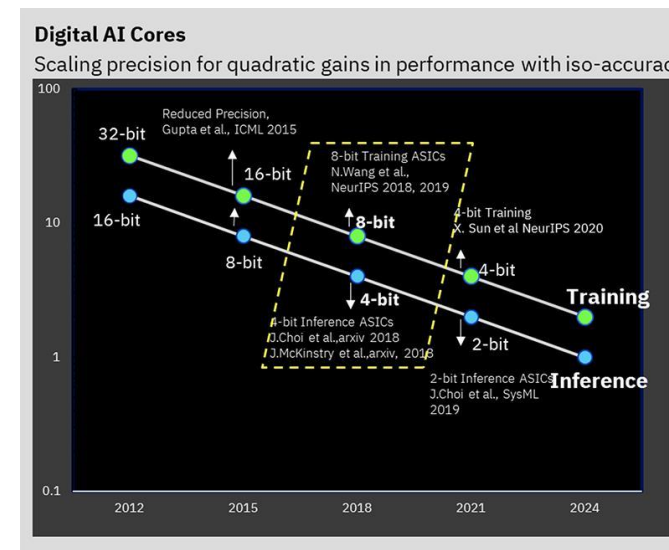
Gen 1
VLSI 2018



Gen 2
VLSI 2020



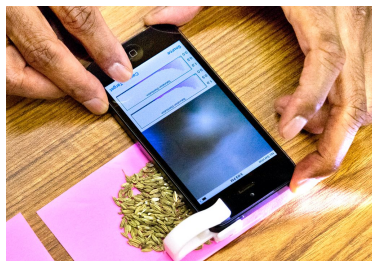
Gen 3
ISSCC 2021



- Many diverse use cases with varying core count, core functionality, memory, power envelope requirements.
 - New SoC for each new application not possible
- Value proposition of Chiplet-based ecosystem: Enable right-sized, modular solutions, integrating AI compute, I/O, and memory chiplets.

Different Use Cases have Different Requirements

IoT / Sensor



< 100 mW
1-5 cores

Mobile



250 mW to <2W

Automotive



20-50W

Data Center



75-300W
Tens to hundreds of cores



AI workloads	Mainly inference	Training and inference
Core count	Small	Large (even larger for training!)
Technology	Low power/older node	High performance/leading node
Power envelope	Low	High
Latency / throughput	Latency critical	Both may be important
Packaging	Low cost	Advanced packaging to support high BW

Chiplets: Composability and Scalability solution for wide variety of use cases
(networks, precision, memory, power envelope)

Chiplet Business Challenges

Design Challenges: Prototyping and Design Tools

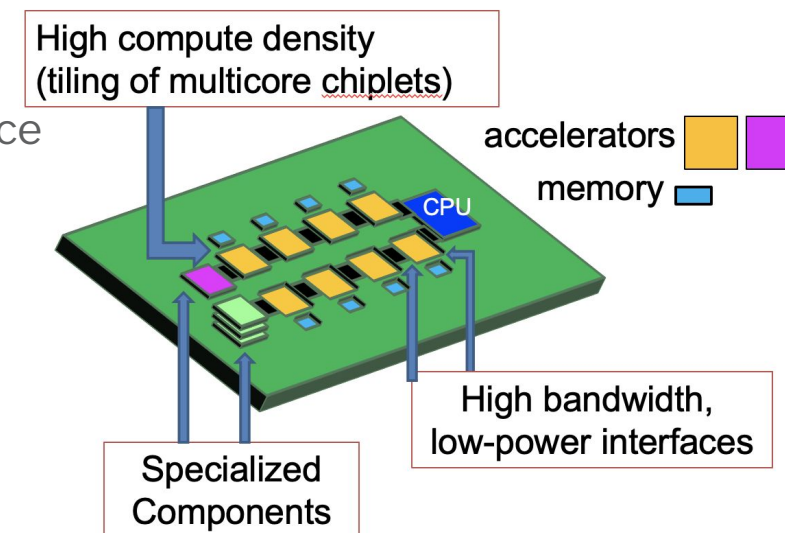
- End-user applications constantly evolving:
New AI Workloads with new networks and different compute/memory balance
- Need for rapid research prototyping of new AI cores (e.g., reuse nest)
- Chiplet+Package+PCB co-design EDA
 - ❖ Standardization of input/output formats across tools
 - ❖ Tools to support full implementation/verification flows (including complex CPI, thermal, etc.)

Build Challenges: Support for broad variety of IP in chiplet format (memory, I/O, accelerators)

- Open standards for I/O interfaces
- Interfaces and Packaging that can meet latency/bandwidth/power/thermal requirements

Deliver Challenges: Multi-vendor flexibility in supply chain

- Interoperability of silicon, package, assembly, test companies and methods to enable flexibility of chiplets and packaging options





Chiplet Business Challenges

A Perspective from Heterogeneous Integration
Roadmap (HIR)

March 12th , 2021

William (Bill) Chen

ASE Group

In Collaboration with Heterogeneous Integration Roadmap (HIR) Technical Working Groups Team



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Heterogeneous Integration Roadmap(HIR) Chapters

Covering the total Microelectronics Systems Ecosystem

System & Market Applications

- High Performance Computing & Data Center
- Mobile
- Medical, Health & Wearables
- Automotive
- IoT
- Aerospace & Defense

Co-Design + Simulation

- Co-Design
- Co-Simulation

Integration Processes

- SiP & Module
- 3D +2D & Interconnect
- WLP (fan in and fan out)

Building Blocks

- Single & Multi Chip Integration + Substrate
- Integrated Photonics
- Integrated Power Electronics
- MEMS & Sensor integration
- 5G Communication & Beyond

Cross Cutting Technologies

- Materials & Emerging Res Materials
- Emerging Research Devices
- Test
- Supply Chain
- Security
- Thermal Management

HIR 4th Annual Conference Feb 24 – 26, 2021

Day 1 Symposium – Day 2 & 3 Cross TWG Workshop

- **Symposium – 6 Plenary Speaker - - Vision on Heterogeneous Future**
 - “Future of Microelectronics after the Pandemic” Ajit Manocha President & CEO SEMI
 - “21st Century Nano System for Abundant-Data Computing”, Subhasish Mitra, Stanford University
 - “Reimagining Co-Design of HPC Systems for a Heterogeneous Future” John Shalf, LBL
 - “Accelerating Electronics & Photonics Innovations for Revolutionary Microsystems” Gordon Keeler DARPA
 - “Thermal Sciences for the Heterogeneous Future” Ken Goodson, Dept., Stanford University
 - “Charge to Heterogeneous Integration Roadmap Teams” Nicky Lu, CEO & Founder, Etron Technology Taiwan
- **Cross TWG Workshop**
 - 8 min presentation from all 22 TWG teams
 - Invited Chiplet speakers: Raja Swaminathan (AMD) & Bapi Vinnokota (ODSA/OCP & Broadcom)
 - SRC Program Director John Oakley on Heterogeneous Integration Science Programs
 - Cross TWG Workshop Value Proposition – The Whole of HIR Roadmap greater than the Sum of individual Chapters
- **Recorded 3 Days Video available.** <https://ieee-region6.org/scv-eps/?p=2416>

Accelerating Electronics and Photonics Innovation for Revolutionary Microsystems

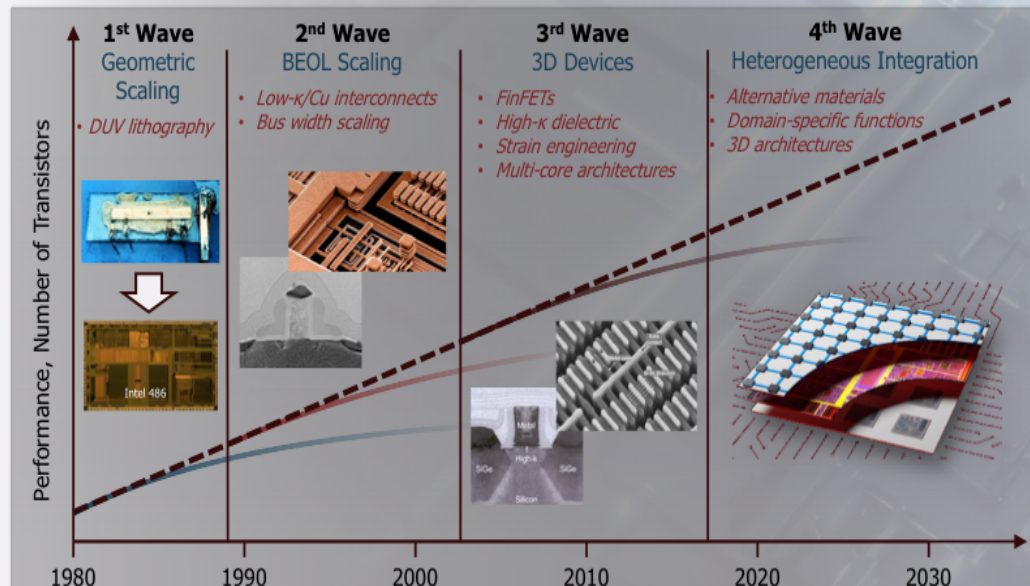
Dr Gordon Keeler

DARPA

February 24, 2021

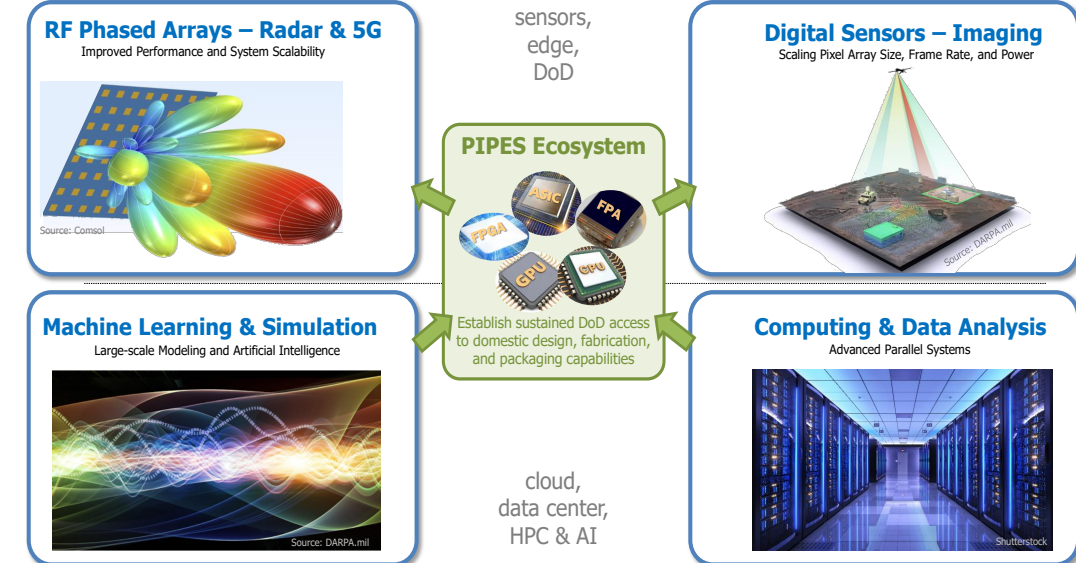
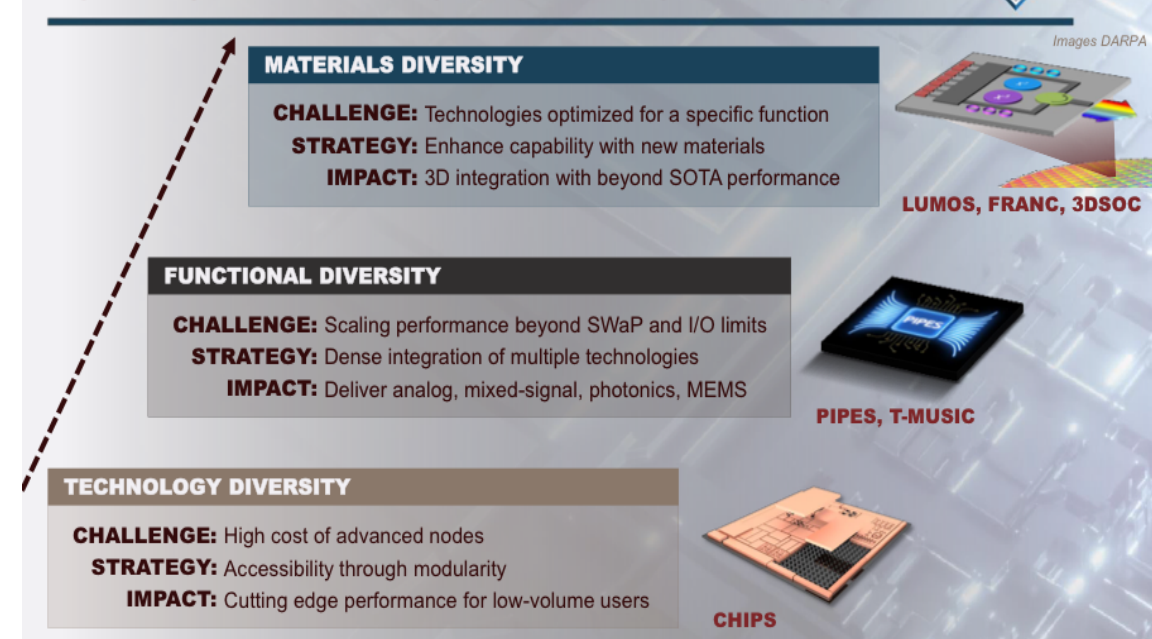
HETEROGENEOUS INTEGRATION

Extending Moore's law and broadening our impact



Video available. <https://ieee-region6.org/scv-eps/?p=2416>

DISTINCT DRIVERS OF INTEGRATION

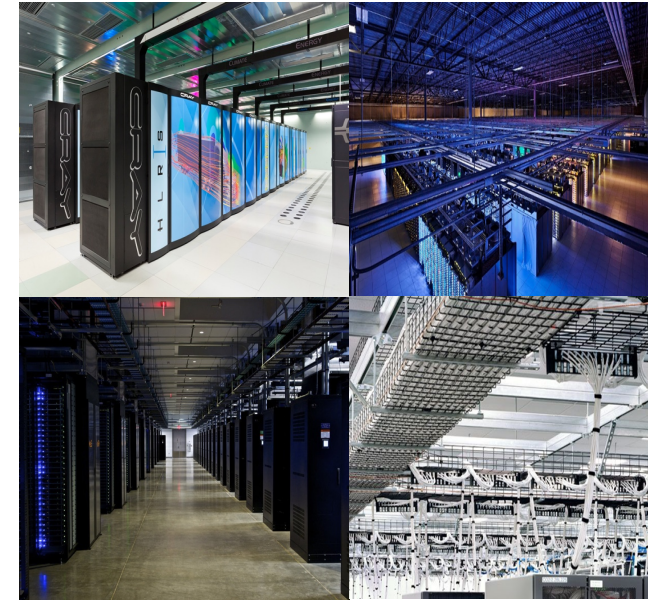


Facilitating DoD Access: Create an ecosystem for package-level optical signaling, enabling disruptive advances for artificial intelligence, phased arrays, sensors and processing.

A slide from the HPC - Data Center TWG Presentation

Acknowledgement: Kanad Ghose Feb 25th ,2021

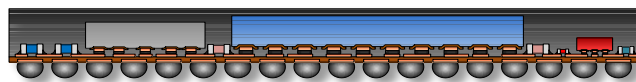
- This TWG focuses on the need, requirements and solutions for realizing **SYSTEM-IN-PACKAGE** that integrate processing elements, accelerators, storage, IO for the following markets:
 - HPC Systems
 - Scale-out Systems
 - Data Centers
 - High-end Networking
- This TWG focuses on the system-level implications related to performance, power management, security, power distribution/conversion issues and others
- Emerging applications demand domain-specific accelerators
 - Analytics/Intelligence on demand
 - Big data processing
 - IoTs and Edge
 - Blockchain processing
- Emerging processing, accelerator and memory technologies, quantum computing driving new system architectures



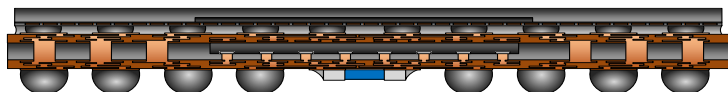
Fan Out Heterogeneous Package Examples

2D & 3D Fan Out Packaging

- Chip Last Fan Out SiP



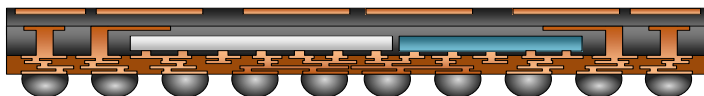
- Double Sided Fan Out POP



- Fan Out SiP with Selective Shielding

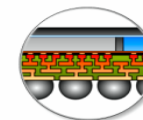
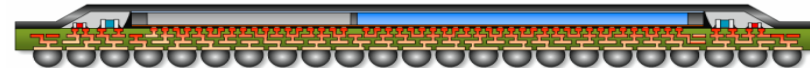


- Fan Out Antenna in Package (AiP)

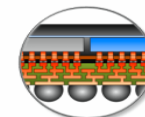
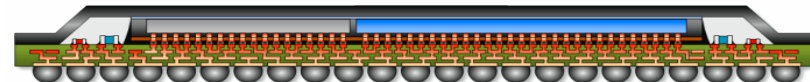


Hybrid Fan Out on Substrate Variations

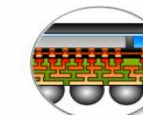
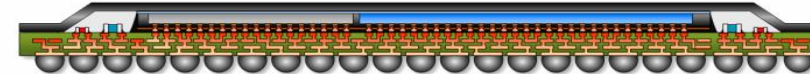
- Chip First Die Down



- Chip First Die Up



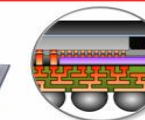
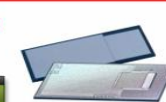
- Chip Last High Density



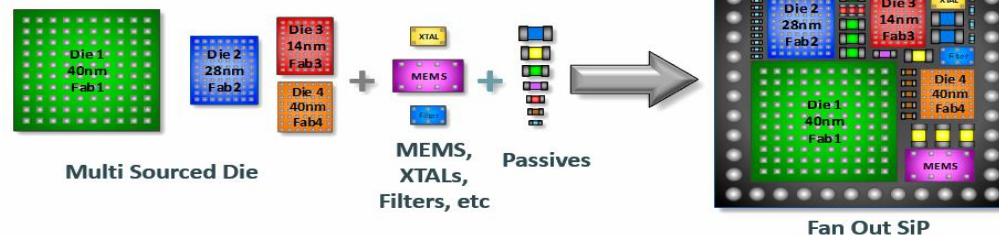
- Chip Last FO w/Bridge



Recent FO Introduction



Fan Out SiP





A Page from the HPC - Data Center TWG Presentation

Acknowledgement: Ken Lanier Feb 25 ,2021

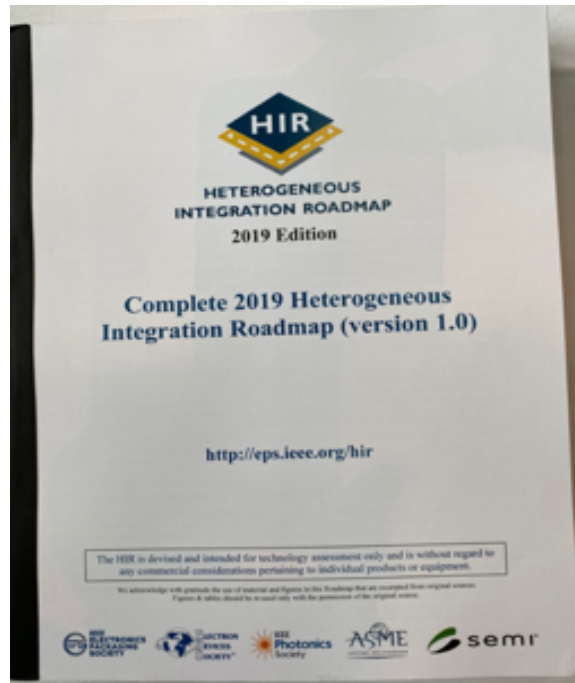


Test Technology Working Group, Heterogeneous Integration Roadmap Leadership Team

Dave Armstrong & Ken Lanier: Co-Chairmen

2.5D/3D device test	Zoe Conroy	Photonic Test	Dave Armstrong
Analog and Mixed-signal Test	Don Blair		Tom Brown
Cost-of-Test	Ken Lanier		Sylwester Latkowski
Data Analytics	Ira Leventhal	RF Test	Don Blair
Logic & SOC Device Test	Marc Hutner	System Level Test	Harry Chen
Memory Test	John Caldwell	Specialty Device Test	Wendy Chen
		Wafer Probe and Device Handling	Jerry Broz

The 2020 update to the test roadmap is output from a team of more than 120 test experts hailing from more than 50 companies world-wide. The leadership team for this effort is shown above.



Launched 10-10-
2109

24 chapters

590 Pages

free download

Download Link

<https://eps.ieee.org/technology/heterogeneous-integration-roadmap>

Heterogeneous Integration Roadmap (HIR)

IEEE Press Release 10-10-2019

PISCATAWAY, N.J.--([BUSINESS WIRE](#))--IEEE, the world's largest technical professional organization dedicated to advancing technology for humanity, today announced the 2019 release of the **Heterogeneous Integration Roadmap (HIR)**, a roadmap to the future of electronics identifying technology requirements and potential solutions. The primary objective is to stimulate pre-competitive collaboration among industry, academia and government to accelerate progress. The roadmap offers professionals, industry, academia and research institutes a comprehensive, strategic forecast of technology over the next 15 years. The HIR also delivers a 25-year projection for heterogeneous integration of emerging devices and materials with longer research-and-development timelines.

- Sponsored by 3 IEEE Societies (EPS, EDS & Photonics) together with SEMI & ASME Electronics & Photonics Packaging Division
- Comprehensively covering microelectronics technology ecosystem
- Articulates state-of-the-art Advances in Technology & Science, Future directions, Significant roadblocks & Potential solutions
- Volunteers (60% industry, 30% Academia, 10% Research Institute)

Wrap-Up

- Since the HIR release Oct 10, 2019, Heterogeneous Integration Roadmap is making its mark in the global electronics ecosystem. Heterogeneous Integration Roadmap journey is off to a strong start
- ODSA & HIR share common objectives in fostering Chiplet Technology & accelerating Chiplet business implementation
- Packaging technologies for Heterogeneous Integration, serve as the crucial link for the design-build-deliver collaboration between the Wafer Foundry and the System Integrator
- AI & ML across stake holder collaboration & data sharing will build trust & mitigating risk across supply chain.

Thank You

william.chen@aseus.com

Acknowledgement : Heterogeneous Integration Roadmap Technical Working Groups Team

HIR Download link <https://eps.ieee.org/echnology/heterogeneous-integration-roadmap>





Chiplets in Heterogeneous Acceleration

Business Opportunities and Challenges

Giri Chukkapalli

Heterogeneous Acceleration

- Computational requirements are growing exponentially,
 - Driven by ML/DL/AI advances
- Application and algorithmic diversity is growing , and
- Loss of general purpose processor perf improvements
 - Due to diminishing Process technology benefits
 - \$/Transistor is increasing
- Architectural innovations to keep pace
 - Resulting in Heterogeneous acceleration
- Potential for Splitting Functional Blocks into Chiplets

Silicon Design Flow

- 4 year design cycle with a delivery cadence of ~18 months
 - Requiring 1.5X team
- Tape out and Wafer costs, EDA tool costs continue to grow
 - Rightfully due to growing complexities
- ~150k Volume with ~50% margin needed to break even
 - Irrespective of size or complexity of the Chip
- Economies of Scale required often from broader set of Chips
 - Very hard to succeed on a single chip design
- Bottomline: There is little slack in Silicon Business
 - Proof is almost all the current Silicon companies
- **CHIPLETS NEED** to improve one or more of the above Business Risks

Chiplets: Use Cases, constraints

- Overcome Reticle limit
 - Perf sensitive
 - Functional, symmetric/perf breakup
 - May require parallel D2D interfaces and custom silicon interposer,
- Bringing Board/System into Package
 - Cost sensitive
 - Serial D2D and organic interposer may be sufficient
- Two distinct issues
 - Silicon companies broadly adopting Chiplets even within their own ecosystem
 - If reticle limit is not an issue, does Chiplets truly provide Perf/TCO?
 - Limitations of EDA Tools, Arch/design space exploration tools that take Chiplets into account
 - Relying on third party Chiplets

Chiplet Tax

- Increased design complexity
- Useful area vs Perimeter area
- Increased Power and latency of On-Die data movement going Off-Die
- Built in redundancy to ameliorate KGD problem
- Increased packaging costs
- Some upfront increased NRE and per Chiplet Tax
- Gov Initiatives and Industry consortium efforts help to establish the Chiplet Ecosystem: DARPA, HIR etc.

Standards vs Innovation

- Premature standardization can kill innovation
 - Standards are antithetical to innovation?
 - If right boundaries/Interfaces are not chosen
- Standards cannot be least common denominator
- Too many open standards is as if no standard
 - Recent serial interface standards effort is the best example
 - CCIX, GenZ, OpenCAPI
 - Finally some convergence to CXL
 - Any lessons learned?



SW Ecosystem for Chiplets

- Mechanical, thermal, power delivery and IO standards
 - Chiplet Architecture Definition Language (cADL?)
- Chiplets management, monitoring SW
- Chiplet Debug SW

Chiplets: Challenges

- Well known Known Good Die (KGD) and all the related issues
- Who owns life time guarantees, Field debug
 - End users may have to share risk atleast initially?
- Risk of relying on a third party Chiplet component for shipping a product
 - Marketplace with multiple choices could solve this problem
 - Chicken and Egg
- Companies of Different Breadth and Depth makes the Chiplet marketplace complicated
 - Key is to reduce risk, cost, time across the whole silicon design flow
 - Real or perceived value transfer could hinder Chiplet marketplace participation

Chiptlets: Opportunities

- Enables separation of Concerns
 - High Complexity, low perf Block can be split off
 - Avoids taping out the whole SoC in case of a bug
 - Can be reused over multiple Gen

Thank you.

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Chipllets for the Masses

Enabling a Vibrant Chiplet Design Ecosystem

Common language lowers design & cost barriers

Standard D2D Interfaces

Different use cases: One size does not fit all

- Parallel & Serial I/F
- Package technology (2D / 2.5D / 3D)
- NoC-to-NoC solution
- Security, Interoperability

Unified 2.5D/3D IC Design Environment

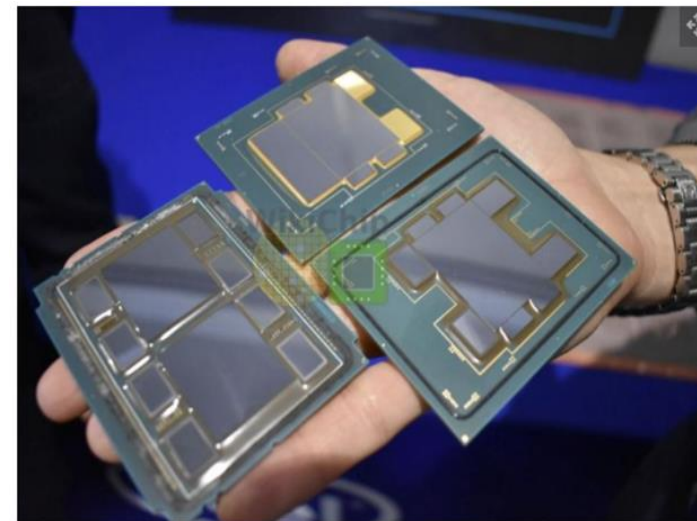
Package / Die co-design and verification tools

- Floor planning / Sims
- Signal & Power Integrity / Thermals

Standard Test Infrastructure

KGD & beyond

- Testability for KGD
- Hierarchical intra- & cross-die testability



(Image credit: @david_schor WikiChip)

Packaging & Assembly directions

Access to Advanced Packaging

3D not for the masses (yet?)

Fanout reduces cost barrier

- Access to “design kit” for design



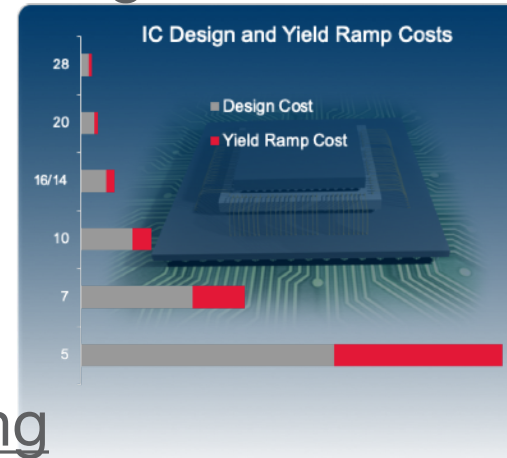
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Business Consideration for Chiplet based compute products

Rishi Chugh , Cadence Design

Business Consideration - Chiplet Based Modular Design

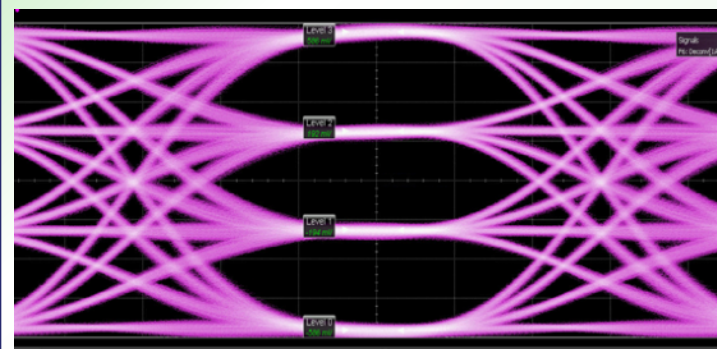
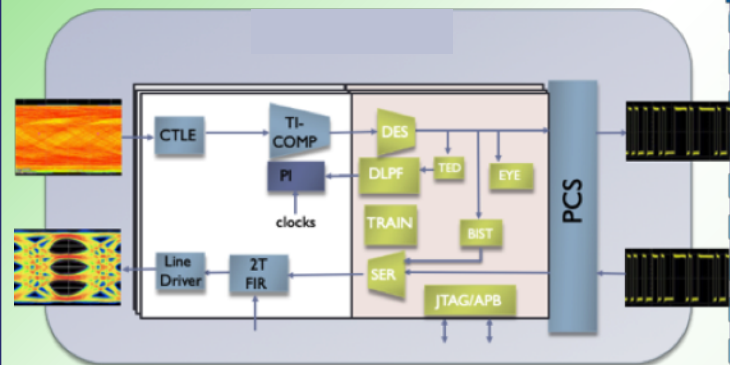
- Leverage SoC design investments across organization to Optimize overall BOM cost
- Optimize investment based off “Node” and “SoC Application” requirement
- Accelerate market adoption by Standardization specific to Chiplet designs :
 - Electrical / Functionality / Features
- Chiplet based design flow for Predictability
 - Methodology / Testability / Integration
- Foundry partner collaboration – Yield & Integration
- Leverage Chiplet design concept for next generation SiP partitioning





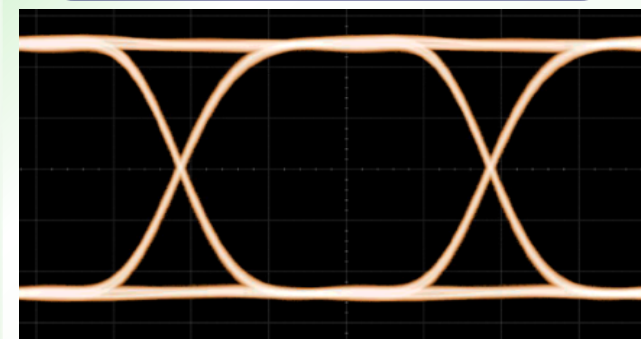
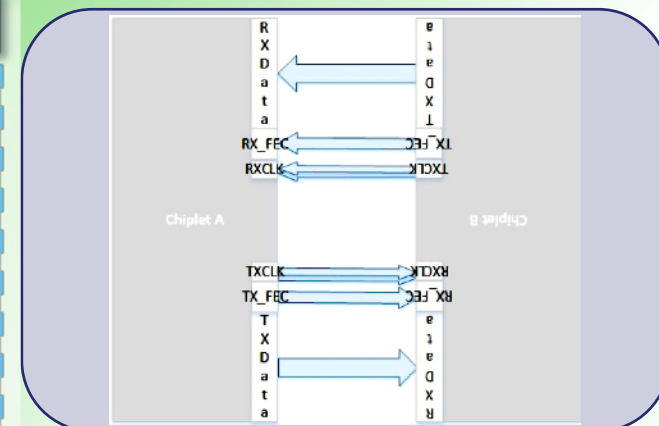
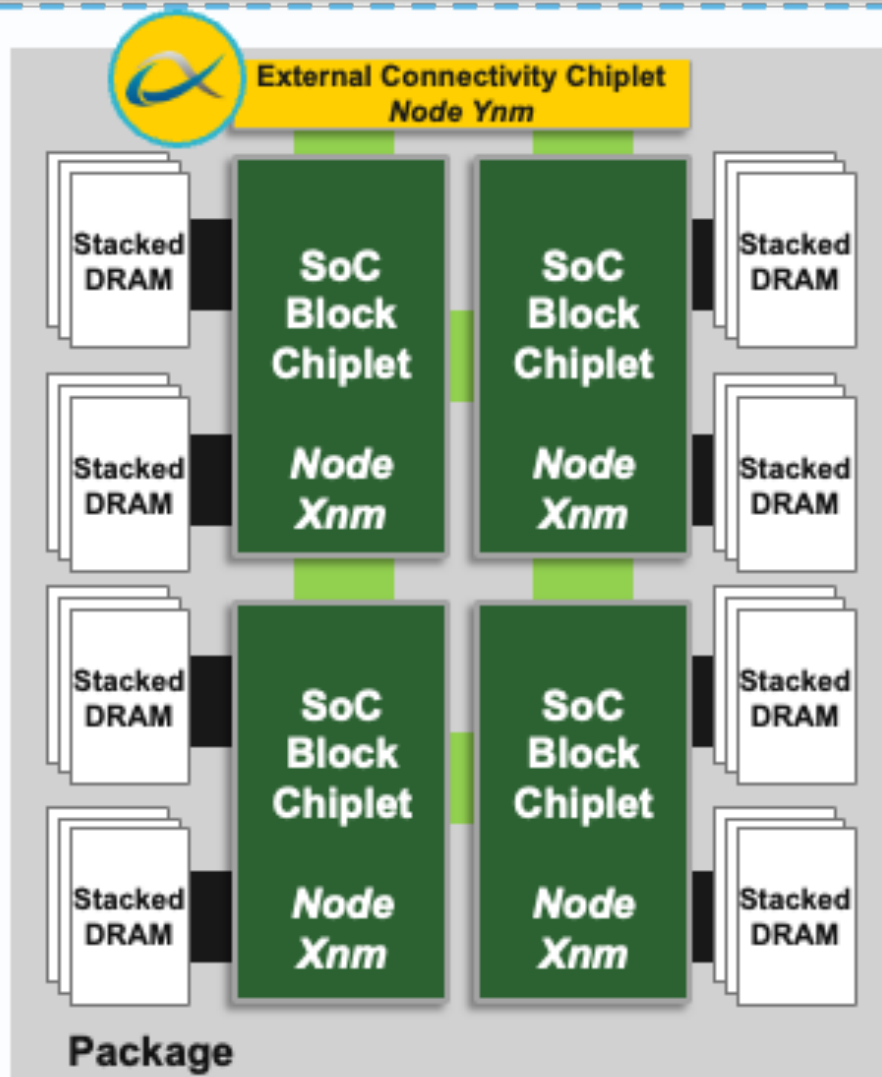
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Serial or Parallel?



- ✓ Organic substrates
- ✓ High Bandwidth
- ✗ Complex interface
- ✗ Higher power, latency

Disintegrated Design with Chiplets



- ✓ Low power, latency
- ✓ Simple interface
- ✗ Requires interposers for high density
- ✗ Complex routing



Chiplet Economic Constraints

--A Builder's Perspective

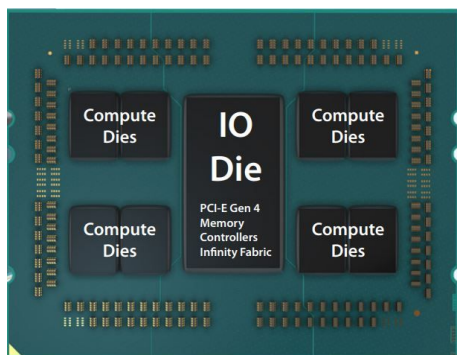
Moderator: Andreas Olofsson, Zero ASIC

Panelists: Eelco Bergman, ASE
Max (Sunghwan) Min, Samsung
Regan Mills, Teradyne
Swami Prasad, JCET

ODSA Goal Restated



INTEL



AMD

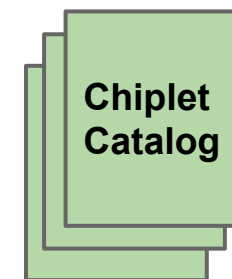


XILINX

Chiplets In Production Today!
(...but only in vertically integrated form)



NEW: 3rd Party
Chiplet Players



Off the Shelf
(in storage or
produced on
demand)

Product
Owner

**Secret
Sauce
Block
Design**

**System
Design**

Foundry

OSAT

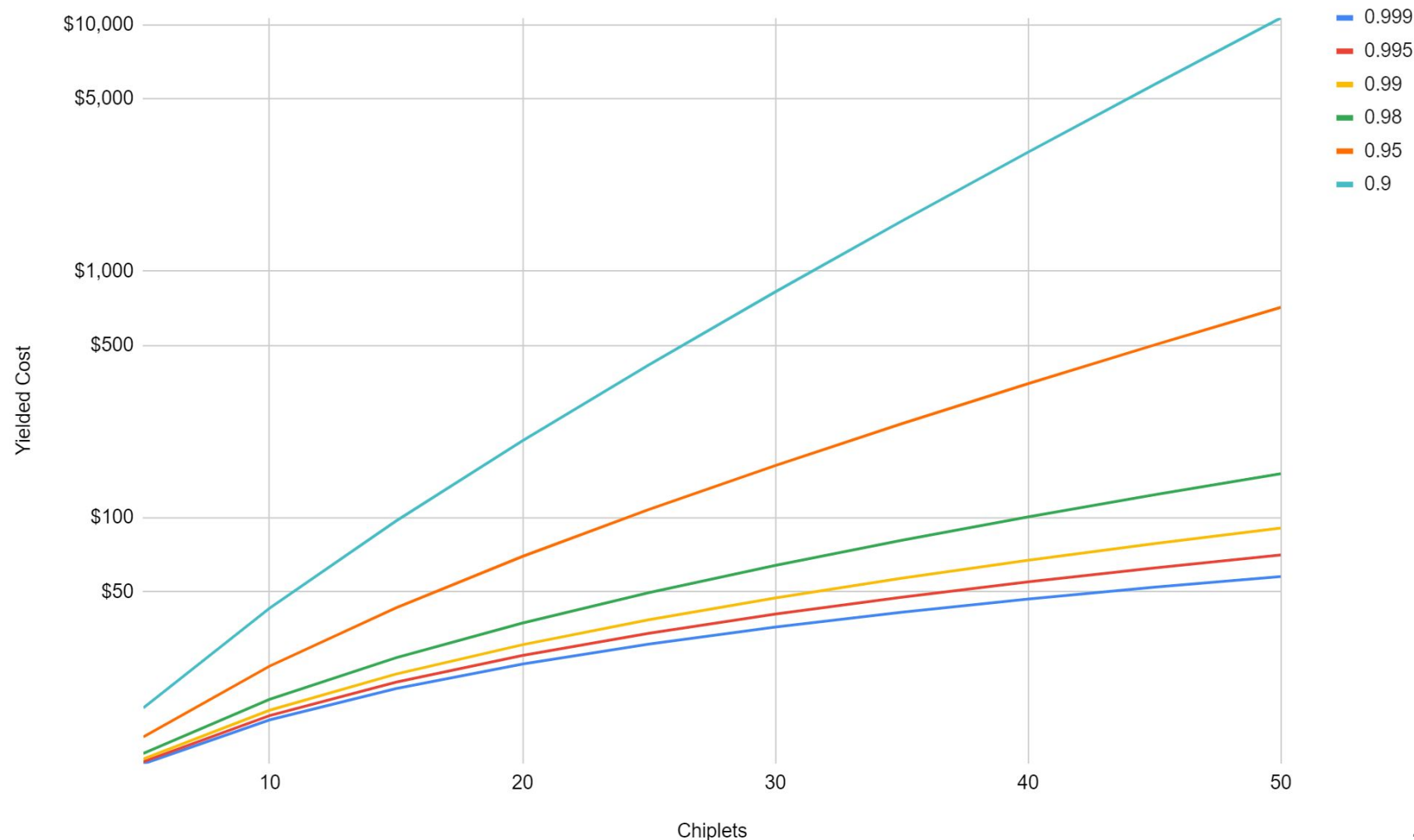
The semiconductor zero sum manufacturing
game grows from 3 players to 3+N players

Builder Business Models

	IP	Foundry	Assembly & Test	PCB Assembly
Input	“ideas”	Raw material Design	Wafers, substrates, interposers, raw materials, test	PCB, packaged parts, raw materials, test program
Output	IP	Wafers	Good parts	Good boards
Market Size	\$5B	\$80B	\$30B	\$4001B
Gross Margin	96%	54%	15%	7%
Setup CostsMargin	0	\$100,000 - \$10M	\$1,000 - \$1M	\$1,000 - \$100,000
Value of Unit Shipped	N/A	1X	1.1X - 2X	2.1X - 4X
Factory Test	N/A	Wafer Acceptance Test	In circuit testing, AOI	In circuit testing, AOI
Design Rules	N/A	Fixed	Variable	Variable
Yield	N/A	10 - 99%	99%	90 - 99%
Bad Unit Cost	N/A	\$0.1 - \$150	\$0.1 - \$1,000	\$1 - \$10,000
Yield Ownership	Customer*	Customer*	Customer*	Customer*
Warranty	Up to license	New Wafers	Variable	Rework/Replacement

Basic Builder Economics

1. Advanced technology is hard and expensive)
2. Advanced technology & high volume is REALLY hard and expensive
3. Advanced technology & high yield & low cost is “MOORE’S LAW” hard



Model: \$1/chiplet, \$5/assembly



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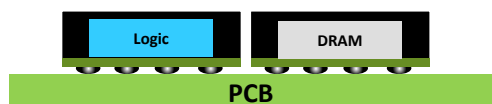
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Foundry View

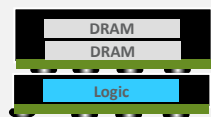
- Max (Sunghwan) Min, Samsung

CUBE for Enabling Chiplet (Samsung Foundry View)

- CUBE is a device (interposer) connecting small and large chiplet(s) horizontally and vertically



(PCB is a device connecting packages)



- + TMV
- + PoP
- + LPDDR (molded chiplet with <0.4mmp)



- + TSV
- + CoW (u-bump)
- + Interposer
- + HBM (molded chiplet with 55ump)



- + Logic TSV
- + D2W Cu-Cu
- + D2D IP
- + Logic chiplet (?)

CUBE examples

Requirement	Solution
Known good active interposer	HBM2/2E/3 (HBM CUBE) Logic on Logic (X CUBE)
Known good SI interposer	Thinned Si interposer (I CUBE)
TSV-less known good interposer	RDL interposer (R CUBE)
Flexible pitch/layer interposer	Embedded bridge (E CUBE)

Challenges to be addressed for enabling chiplet

- Heterogeneous (logic A/B + memory 1/2 + D2D α/β + decap + ...) integration with OSAT and IP partners
- Lots of test vehicles (MTV, TTV, FTV, CPI, ...) confirming PPA (W, Hz, mm²) feasibility
 - Thermal & mechanical integrity
 - Signal & power integrity
 - Form factor
- Known good chiplet and CUBE (yield)



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Assembly & Test

- ASE – Eelco Bergman
- JCET– Swami Prasad
- Teradyne – Regan Mills



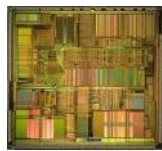
ASE GROUP

JCET

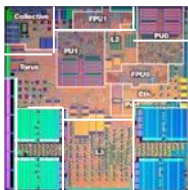
TERADYNE

Converging Solutions & Business Models

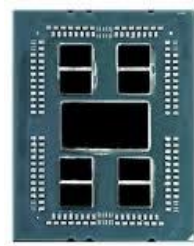
OSAT & EMS



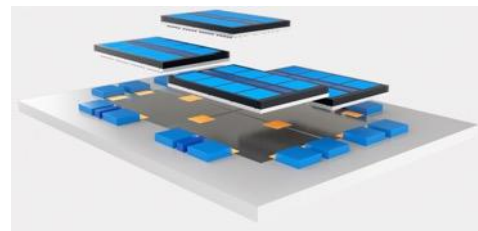
1990's



2000's

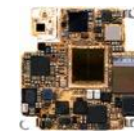


2010's



2020's

2010's



2000's



1990's



Wearable SiP

Smartphone System Board

PC Mother Board

Monolithic SoC

SoC w/ Integrated IP

Disaggregated SoC

Virtual SoC

3rd Party IP Chiplets
KGD/KGC
Homo/Hetero Int.
3DIC / Hybrid Bond
Organic or Si
substrate

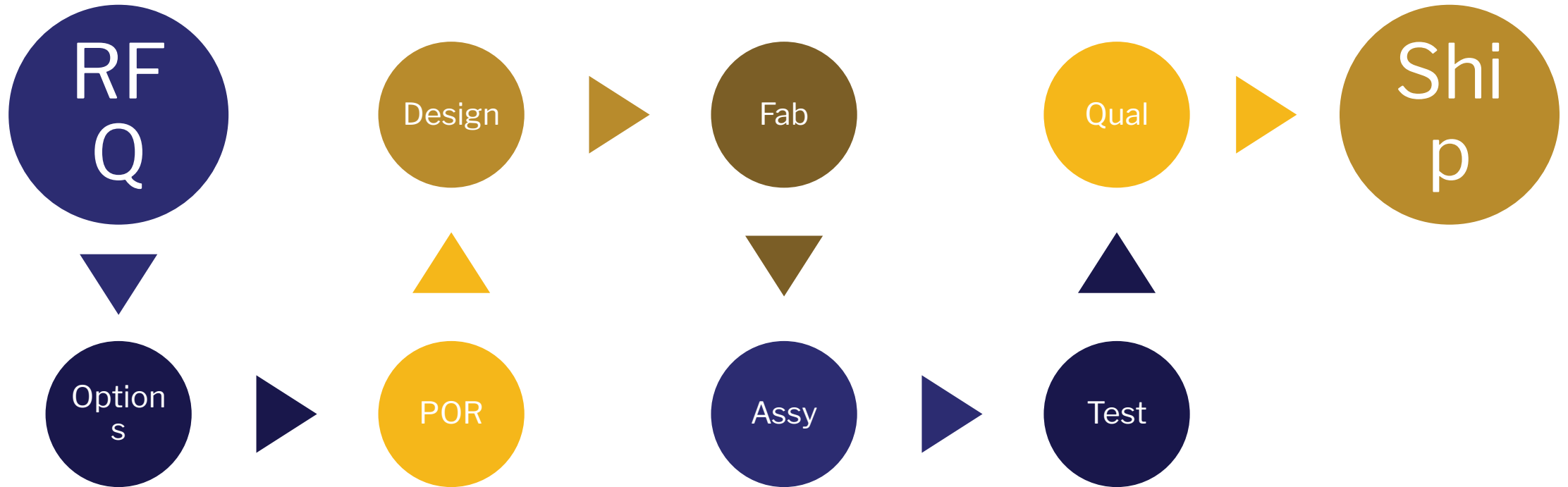
Single Die
Probed Die
Wire Bond
Die Integration

MCM
KGD
2.xD Flip Chip
Pkg Integration

MCM
KGD
2D Flip Chip
Bare die

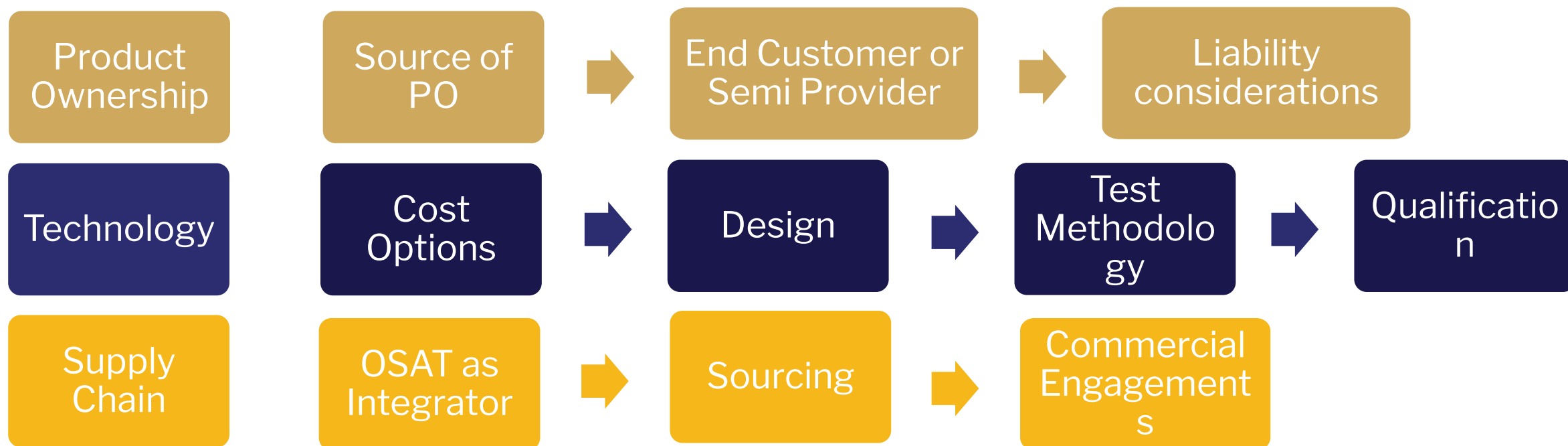
PCBA
Tested Components
SMT
Packaged Die

Single Die/Current Business Flow



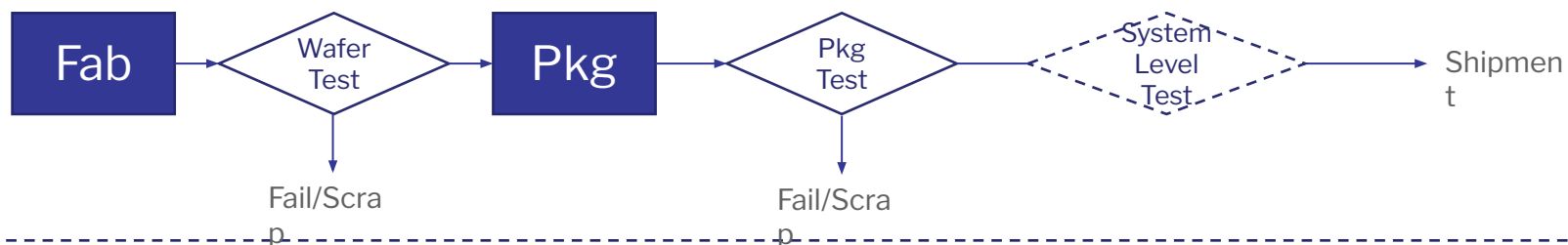
- POR : Package, Test Specs provided by the customer
- Silicon, Memory Package/s are consigned
- Substrate, Passives can be consigned or purchased
- Process Flow - Wafer Sort, Assembly, Final Test/System Level Test

Chiplet Business Flow



Value of Quality – A Shift with Chiplets

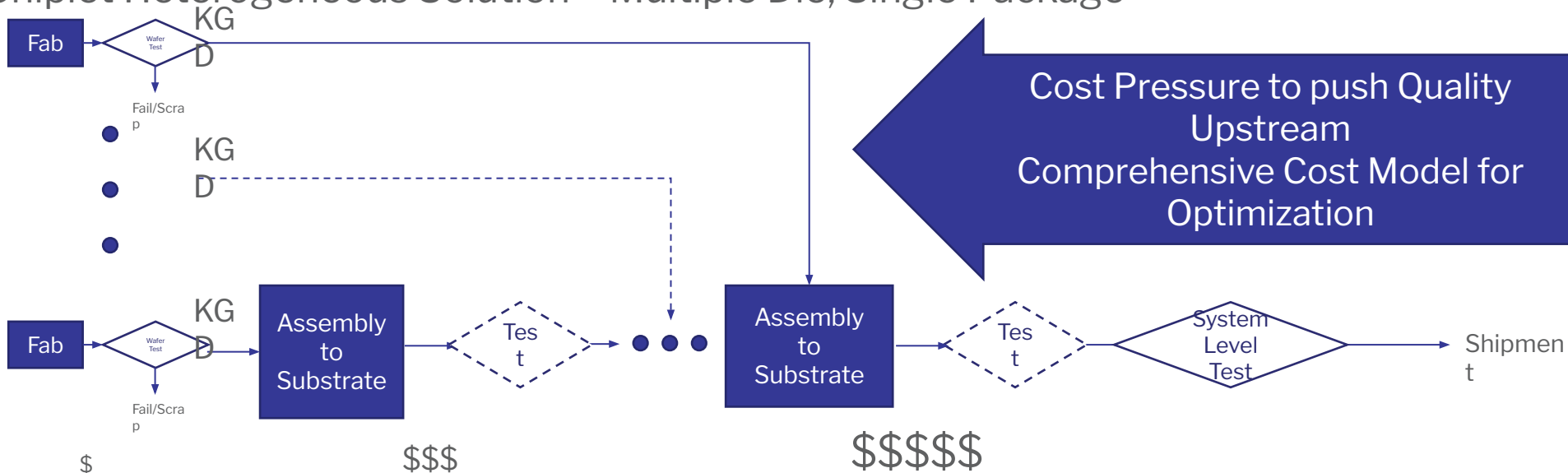
Monolithic Silicon – Single Die, Single Package



Cost Factors

- SLT req'd for some devices to achieve AQLs
- Potential to move SCAN in SLT to reduce cost

Chiplet Heterogeneous Solution – Multiple Die, Single Package



Cost Factors

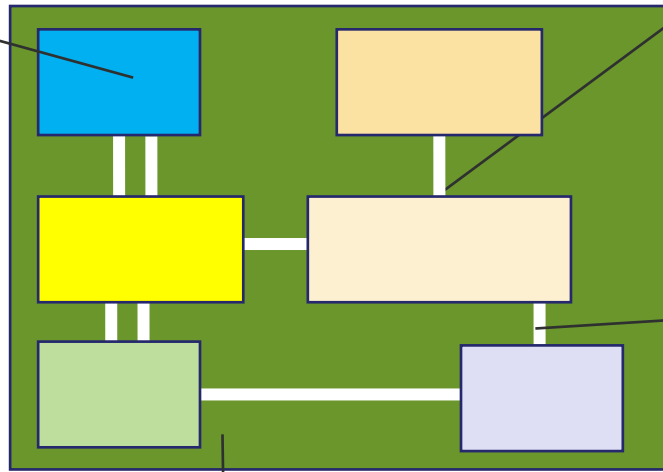
- Rapidly accumulating costs as die are mounted
- No/Limited rework capability (different than PCB assembly)
- Cost of bad die drives KGD methodology
- Possible need for intermediate test of assembly to maximize yield at final stage
- Pre-combinations of die (single supplier cubes) viable to reduce the multiplicative impact of yield

Chiplet Manufacturing

Packaging and Test Technical Considerations Directly Impact Economics

Quality - Known Good Die

- Who is responsible for quality of die?
- What is the economic model for an escaped bad die? Cost of a simple IP chiplet may be insignificant to the cost of the ruined assembly.
- How to ensure quality of substrate?
- Testability concerns with IP blocks which are designed to be verifiable but not testable in stand-alone manufactured state; additional die area (cost adder) may be required for testability



Interoperability

- Extension of existing test standards required to allow efficient test setup for interface/interoperability testing
- Industry adoption of test standards will drive test costs down

High Speed Interfaces

- Driver strength limited for cost reasons, need test bumps and drivers
- Die loopback & adequate design margin for economic wafer test to support KGD
- HBM-like redundancy viable in some cases

High Speed Interconnects

- Substrate a key part of system performance => is substrate test required?
- Full system level test likely required to find 2nd order interactions between die and substrate -> full system simulation environment key to yield at EOL



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Thank You

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Accelerate.

Deliver / Business Panel

- Moderator: Dave Greenfield - Intel
- **System Integrator**
Microchip: Anu Ramamurthy
Marvell: Ramin Frajadrad
- **End Users**
Google: Ben Kerr
Alibaba: Weifeng Zhang
FB: Nicolaas Viljoen
Microsoft: Ishwar Agarwal

Chiplet Business Collaboration

Dave Greenfield – Intel Corporation

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Agenda

- What's the problem?
- Scope the opportunity
- Case Study: identify key challenges
- Additional “learning

Value in Wireless Radio – 25% Lower System Power

10-20x reduction (50W - 100W) reduction in interface power

Use Case I/O Power Example

Parameter	Sub-6GHz NR
RF frequency	3.5-6GHz
Number of TR	64T/64R ¹
IBW (MHz)	200
JESD204C lanes ²	53
JESD power now (W) ³	106
JESD power future(W) ³	53
AIB power now (W) ⁴	5.3



Power is too high

There must be a **compelling** reason to use MCP vs. discrete option!

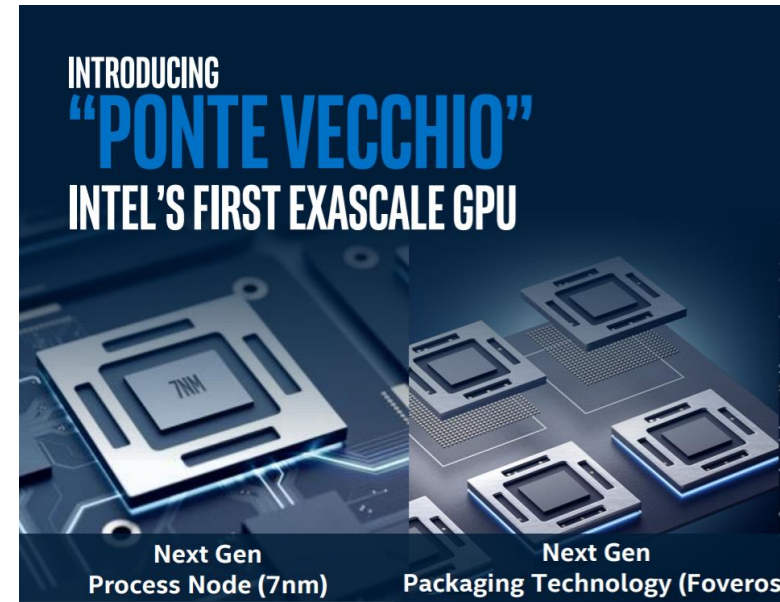
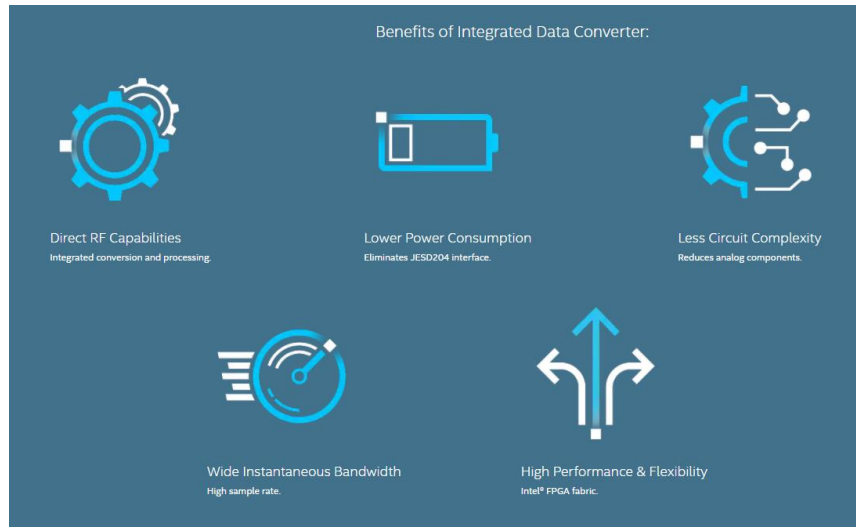
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Intel Disaggregated Design

- Intel developed POC with DARPA CHIPS program partnering with external supplier
- Intel released analog FPGA technology announcement in Q4-2020 to enable future products
- Intel Programmable Solutions Group (Altera) leader is disaggregation strategy



- <https://www.intel.com/content/www/us/en/architecture-and-technology/programmable/analog-rf-fpga.html>
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Business Case for MCP

- What's the cost to productize the MCP (probably not 6-digit cost)?
 - Who's doing the work?
 - How extensive is validation work?
 - How many units needed for volume validation?
- Do the chiplets exist (off-the-shelf vs. development project)?
 - Significantly different set of challenges if 2nd party needs to develop new chiplet
 - Why bring in development partner?
- What's the market opportunity?
 - Size the market, assess the risk, estimate time to productize . . .



FPGA Case Study

- How do we share the revenue?
- How handle IP ownership?
- How address supplier risk (acquisition / continuity of supply)?
- How connect with supply team?
- How address funding challenge (development & productization)?

The “Deal”

- Key Term Sheet Details
 - NRE to accelerate product development
 - KGD deal with escrow provisions
 - IP: define ownership & license rights
 - Define exclusivity terms
 - Define impact of schedule delays (who takes on product risk)?
 - What if known **good** die isn't actually **good**? Yield fallout (chiplet could be low % of high MCP cost) – define acceptable defect density & resulting terms?

Extra Provisions (Stuff We Learned Along the Way)

- Units for test (need a large amount of die) – who pays & what price?
- Who owns IP rights to packaging IP between chiplets?
- How much uncertainty on technical issues with SOW can we live with?

Summary

- Find a pathfinding opportunity for business model and KGD exploration
- Easier to deal with revenue sharing challenges in market where there is ample margin to share than in cost sensitive market
- Identify a compelling technology solution (size, weight, power, cost, yield . . .) vs. finding a market that wants to save area

Chiplet Business Enablement 'Deliver Panel'

Anu Ramamurthy – Microchip Technology

March 2021

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Chiplet Business Problems to Solve

Cost Reduction

- Re-use existing silicon
- Reduce R&D cost
- Fast product SKU development

Standardization

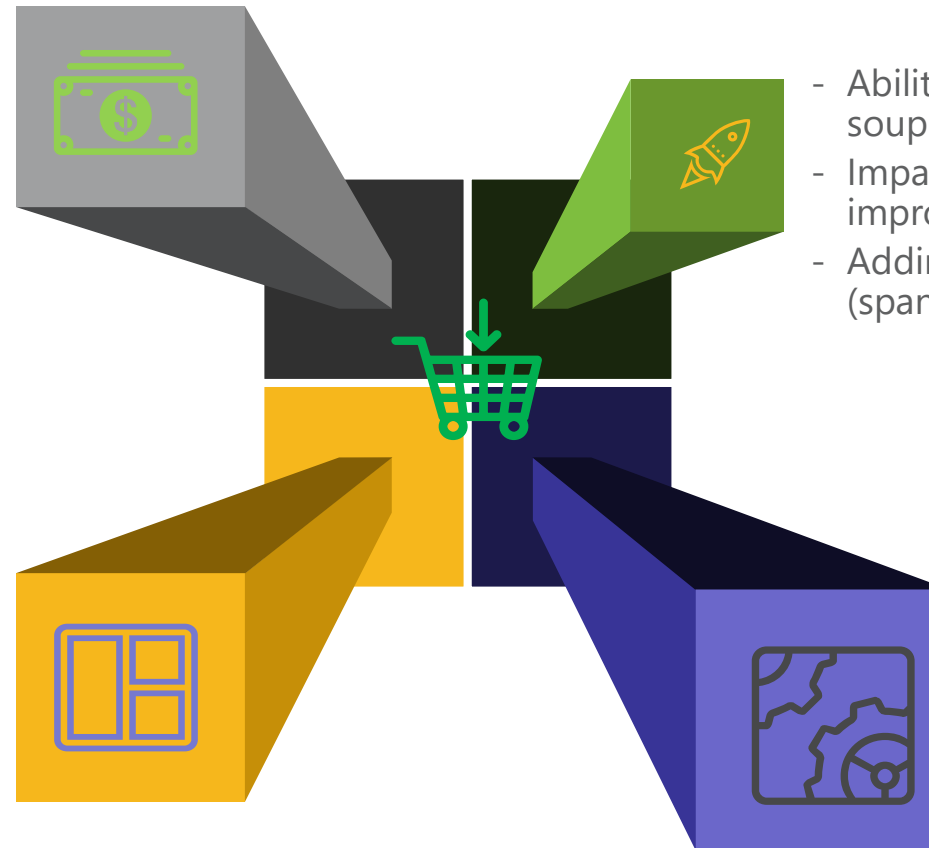
- D2D interface supporting variety of packaging options
- Pin templates for multi-vendor integration

Fast Innovation

- Ability to innovate at different process nodes – no soup to nuts in 3nm
- Impact operation costs via smaller die and improved yields
- Adding 3rd party IP into Microchip IP library (spanning 300nm-6nm)

Operations

- Agreed upon KGD tests to allow foundries to ship to OSATs for assembly and integration
- Common security protocols across supply chain
- Solid Supply chain



Allows for more players in the market and creates a viable ecosystem

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Delivering Chiplet-based Products

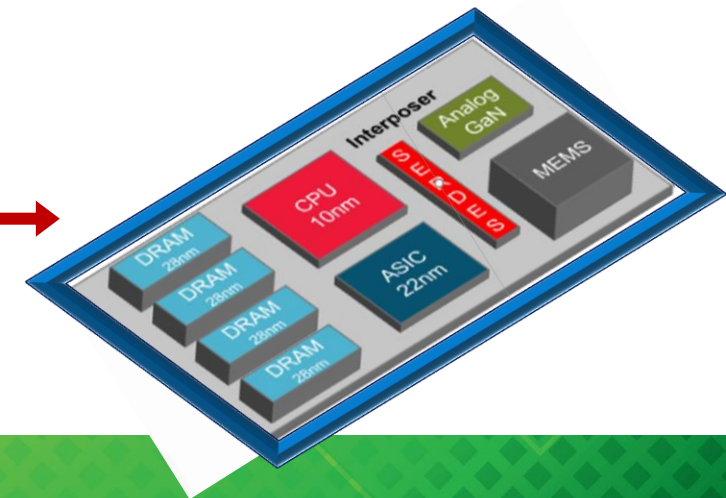
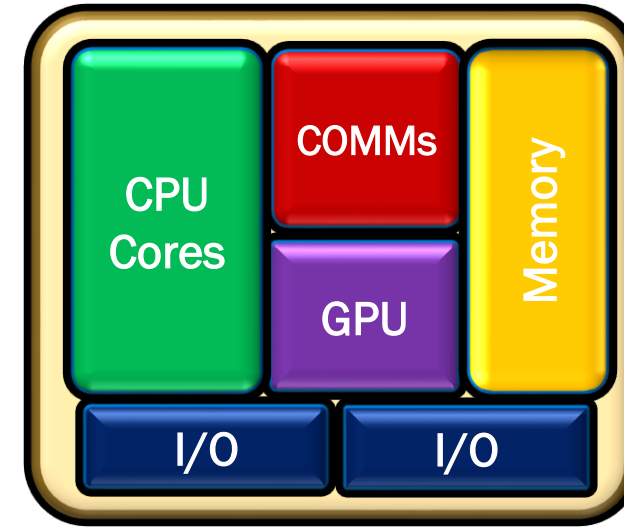
Ramin Farjadrad

CTO & VP of Automotive/Networking PHYs

Marvell

Chiplet-based use cases

- **Large SoC Disaggregation**
 - Partition large die to improve yield
 - Reduce development cost & time-to-market
 - Use optimized process technology per functions
- **System-in-Package (SiP)**
 - Higher performance systems
 - Smaller footprint
 - Lower power



Building systems with chips vs chiplets

Chiplet-based Systems can be built similar to systems with Chips today

— Conventional System OEMs

- Receive good Chips screened at production test
- Connect good Chips together with **Interoperable Standard interfaces***
 - **PHY Layer:** PCIe, DDR Bus
 - **MAC Layer:** CXL, DDR Controller
- Test the final system

— System-in-Package OEMs

- Receive known-good-die (KGD) screened at wafer test
- Connect KGD Chiplets together with **Interoperable Standard interfaces***
 - **PHY Layer:** XSR, BoW, HBM
 - **MAC Layer:** AXL, CXL, HBM Controller
- Test the final System in Package (SiP)

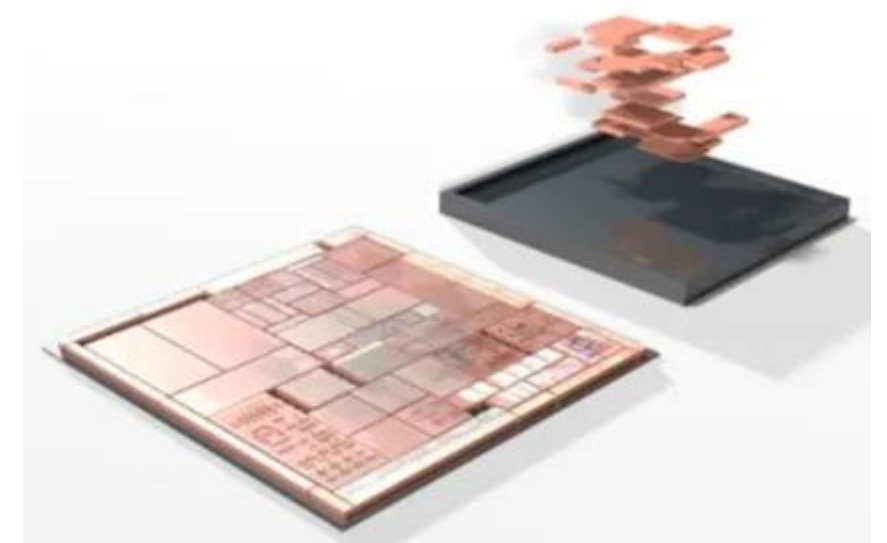
* Proprietary interfaces are perfect options for vertical integration/Captive Systems



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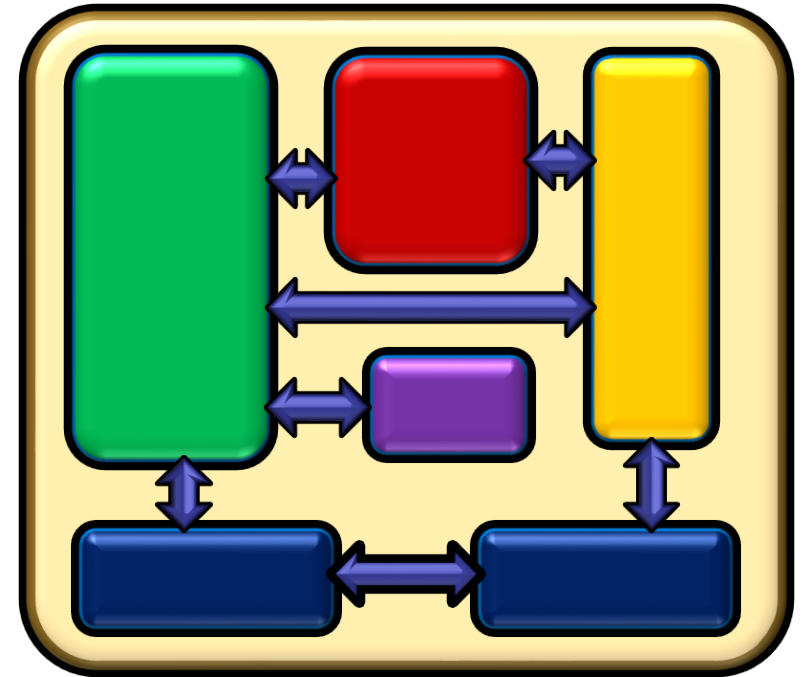
Interface routability is the KEY

- Without D2D routability, all Chiplets need to perfectly match side by side
 - Cannot have **one-size-fit-all** Chiplets
 - Exceptions: New ASICs that can be designed to fit nicely with all Chiplets
- Proper D2D routability is required to enable SiP implementation with off-the-shelf Chiplets
 - Chiplets-based SiPs should have PHYs with reasonable reach (~1 inch)
 - Similar to conventional systems,

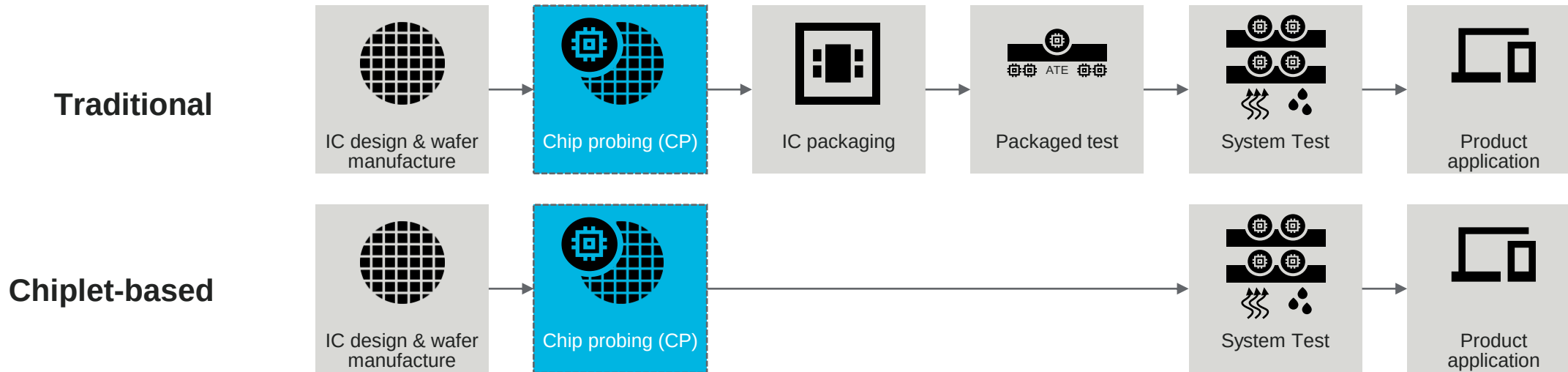


Interface routability is the KEY

- Without D2D routability, all Chiplets need to perfectly match side by side
 - It defines the purpose of Chiplet-based systems, if we need to build several Chiplets per function with different dimensions optimized for target system
 - Exceptions: New ASICs that can be designed to fit nicely with all Chiplets
- Proper D2D routability is required to enable SiP implementation with off-the-shelf Chiplets
 - Similar to conventional systems, Chiplets-based SiPs should have PHYs with reasonable reach (~1 inch)



High-coverage screening is a necessity



— Chiplet screening challenge

- KGD screening must happen at Wafer level
- Wafer-level test coverage must be high
 - Yield target >99%

— The μ -bump challenge:

- Wafer probe limitations with μ -bump limits screening coverage
- High-speed interconnect coverage
 - At-speed full-link test not possible

Summary

- **Chiplets can be potentially marketed/sold like traditional Chips**
- **Similar key processes need to exist**
 - Standardization of Interface for Inter-Chiplet links
 - Routability of links for practical Chiplet placements
 - Wafer-level screening with high defect coverage
 - A challenge for Chiplets with μ -bumps
- **Support to be similar to today's SoC/System model. SiP vendors**
 - will be responsible to support their direct customers
 - work with their Chiplet providers to resolve their SiP issues

ODSA End User Session

Alibaba, Facebook, Google, Microsoft

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Disclaimer

SLIDE CONTENT REPRESENTS THE COLLECTIVE VIEW OF ALL ODSA
END USER WORK GROUP MEMBERS, AND DOES NOT REPRESENT THE
POSITION OF ONE SPECIFIC MEMBER.

Enabling a Chiplet Marketplace

- The Need for Chiplets
- “Gaps” and “Gives”
 - Business and Commercial
 - Technical
 - Software and Management
- Chiplet Opportunity

The Need for Chiplets

- Critical system IPs are not scaling at the same pace as logic
- Large, monolithic die yield badly
- Fab cycles are longer at advanced nodes
- Faster time-to-market leveraging proven chiplets
- Clear need to **enable a chiplet marketplace ecosystem**

Business and Commercial

Gaps	Gives
● Multi-source die available from >1 supplier ● Supply chain guarantees ● OSAT complexity, inventory, availability and capacity ● Business model innovation	● Known-Good Die (KGD) supply model ● Broad IP availability ● Established distribution channels

Technical

Gaps

- Open Chiplet Specification (work in progress)
 - Common die footprints with multiple form-factors
 - Die-to-die interfaces
 - ODSA BoW and OpenHBI physical layer
 - Protocol adapters
 - Datasheet parameters
 - Design collateral
- Reference designs for characterization and interoperability

Software and Management

Gaps	Gives
● Robust and secure chiplet discovery mechanism ● Chiplet telemetry data ● Managing package-level resources	● Simple out-of-band hardware interface ● Open management interface and protocol ● Common, extensible management API
Open Chiplet Specification	

End-User Chiplet Applications

- BoW to PCI-Express
 - External interface and self-contained end-point ([backup](#))
- BoW to many other high-speed interfaces
 - Usage in data-comms (LAN & WAN), tele-comms (5G/OpenRAN), proprietary intra- and inter-rack comms
- Enabling system expansion through SKU modularity
- Advanced interconnect solutions

Chiplet Opportunity

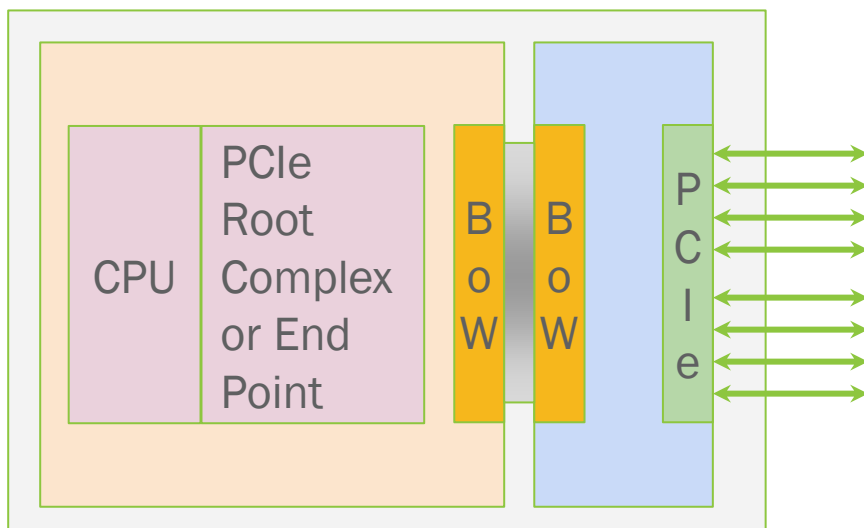
- Chiplet marketplace TAM is potentially very large
- “Gives” are well understood and there are many development threads are in flight within ODSA
- “Gaps” are solvable - the industry already knows how to do this
 - Open Chiplet Specification
- The chiplet marketplace ecosystem momentum is building...

Backup

Available for reference during panel session

PCI-Express Chiplet Solutions

#1: PCIe PHY



#2: PCIe Expansion

